

# Protection for EOS for IEEE1394 Lines With TPD4S1394

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## ABSTRACT

The IEEE 1394 interface is a serial bus interface standard for high-speed communications and isochronous real-time data transfer. It is frequently used by personal computers, as well as in digital audio, digital video, automotive, and aeronautics applications. All 1394 PHY devices are susceptible to electrical overstress damage when exposed to a combination of high-voltage cable power and a faulty cable or connector system that allows data (TPx) and cable power (Vp) connections to engage before the cable ground (Vg) connection. This set of circumstances is known as a "Late-Vg" event. Though there are many ways to take precautions against this event, a robust solution is to disconnect the power to the cable when late-Vg occurs.

The information in this application report is intended to help customer/system designers understand how to design a late-Vg protection circuit in their systems using the TPD4S1394.

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## 1 Introduction

The IEEE 1394A-2000 specification calls for 1394 cable power (Vp) to range from 8 VDC up to 30VDC with a maximum current of 1.5 A. Legacy IEEE 1394-1995 systems can support cable power of 8 VDC up to 40 VDC, also with a maximum current of 1.5A. A typical 1394 PHY device has an absolute maximum input voltage rating of –0.5 VDC to VDD + 0.5 VDC, where the maximum value of VDD is 4.0 VDC. There is an obvious potential for catastrophic damage to a 1394 PHY device if the voltage levels of Vp (~30V) are presented on the differential pair signals of the 1394 PHY device.

If the Vp connection and any of the data (TPx) connections of two 1394 nodes are engaged before the Vg connection, high voltage can appear on the TPx signals in what is known as a *late-Vg* event. The IEEE 1394-1995 specification requires that the Vg and the Vp pins of the connector receptacle are approximately 15% longer to help ensure that these connections are "first make, last break", but this can be compromised if a cable is inserted at an extreme angle. Also, if the Vg connection is not well connected due to distressed cables or connectors, there is also a potential for a late-Vg event.

## 2 System Information

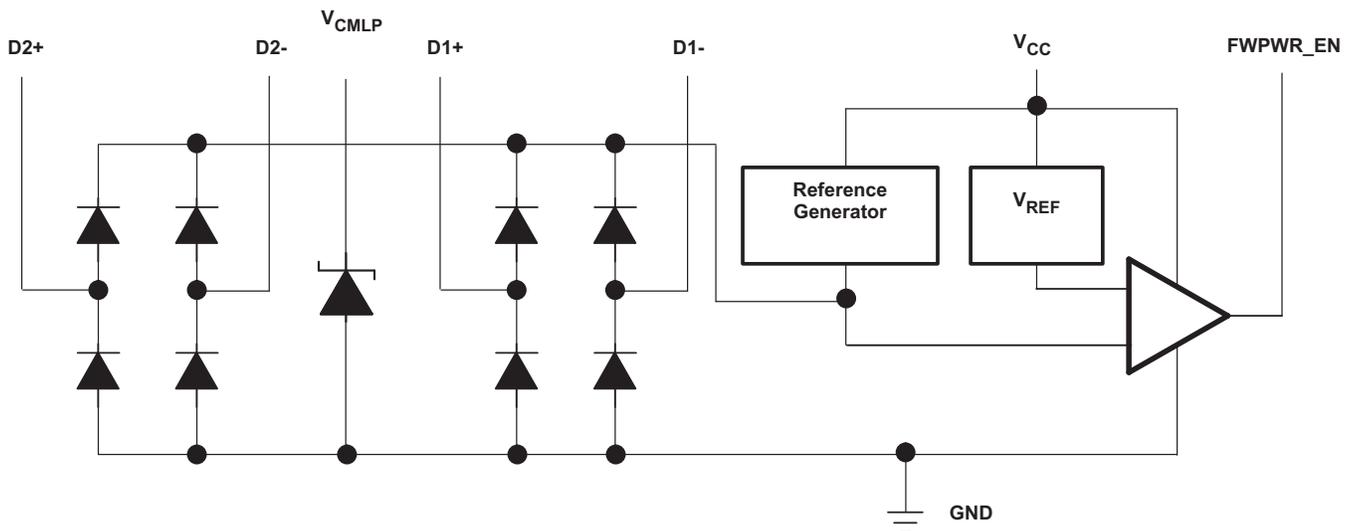
In a typical application, we see that the 1394 port is powered from an external port power supply which can range from 24V to 40V. As describe above, an occurrence of late-Vg event can cause catastrophic damage at such levels.

In cable powered systems, we see that the damage caused by a late-Vg event is due to cable power that is seeking a return path, thus systems that rely heavily on 1394 cable power are more likely to see late-Vg damage. The IEEE 1394A-2000 specification limits Vp supported on the 1394 bus to 30VDC. Typical PC applications source 10 VDC–12 VDC on Vp driven by the PCI bus. Damage to 1394 PHY devices due to a late-Vg event occurs most often on systems with Vp greater than 15VDC. Using older or worn out cables can also cause the late-Vg event to trigger by not allowing the Vg pin to make good contact. The 6-pin connectors are more susceptible to a late-Vg failure than the 9-pin ones.

Since the 1394 ports are externally exposed, it is important to have IEC level ESD protection on the Tp pins. For transmitting the high data rates of IEEE 1394, Tp pin capacitance must be kept low to meet the specification requirement. It is important to ensure that the IEC protection devices do not add too much additional capacitance and harm the data transmission eye-diagram requirement.

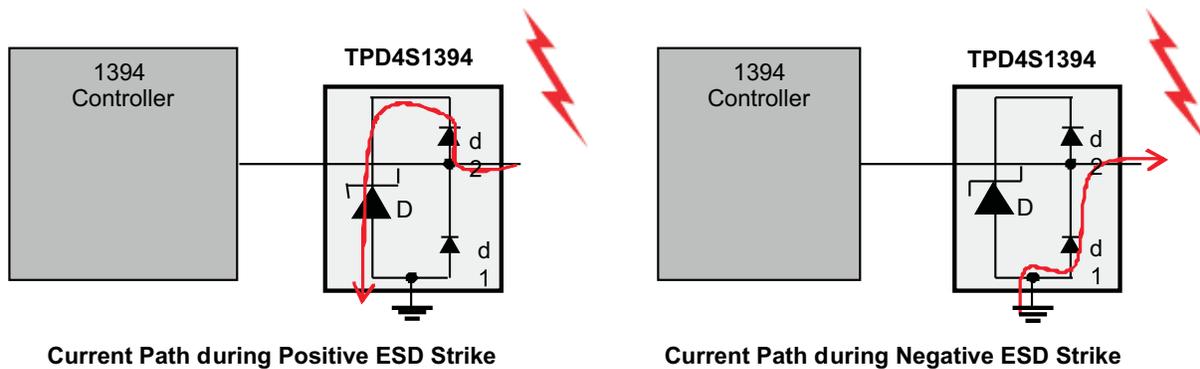
One approach to late-Vg protection is to use the breakdown of the ESD diodes to clamp the voltage to the PHY such that the majority of the late-Vg current flows through the ESD diodes thereby protecting the 1394 port/controller. In this case the ESD diodes only act as a bypass path and hence don't completely solve the problem as late-Vg is not an ESD event. There is still a risk present that the ESD clamping voltage presented to the PHY during a late-Vg event may harm the reliability of the device and damage it permanently.

## 3 Device Architecture



**Figure 1. Block Diagram of TPD4S1394**

Shown in [Figure 1](#) is an internal block diagram of the TPD4S1394. It is comprised of 4 TVS type ESD clamp circuits, reference generators and a comparator. The ESD clamp circuits of the TPDS1394 are capable of providing IEC61000-4-2 (Level 4) system level ESD protection at the TP lines of the 1394 interface. In addition, these pins are rated at  $\pm 15\text{kV}$  HBM.



**Figure 2. Current Path for IEC ESD Stress (Only One ESD Clamp Circuit is Shown)**

The internal comparator with hysteresis is present to detect if an occurrence of late-Vg has taken place. Two internal references are used to determine if the Tp lines remain within acceptable voltage levels under normal mode of operation. The built in ESD protection devices work with the internal analog circuits to make sure that even under the event of an IEC or late-Vg, the internal circuits are protected and switch back to normal operation after the event has disappeared. The VOH level for FWPWR\_EN output is  $\geq 0.7V_{cc}$  at 10mA and the VOL level is  $\leq 0.3V_{cc}$  at 10mA. The high level of the FWPWR\_EN is referenced to the Vcc supply of the chip.

Referring to [Figure 2](#), the TPD4S1394 employs a three diode configuration to implement the system level ESD solution at the 1394 TPx data lines. The central diode, D, is much larger in size and associates with higher capacitance to GND. The d1 and d2 diodes are much smaller in size and work to hide the larger capacitance of the central diode D. Since the TPx data lines are connected to d1, d2 diodes, the data lines are exposed to lower capacitance (1.5pF IO to GND) of the d1, d2 diodes only. During positive ESD strike, the central diode D breaks down and offers current path through d1 and D to GND and keeps the signal line from going too far above the supply rail. During negative ESD strike, the diode d2 conducts and keeps the signal line from going too far below ground. These diodes and their metal system are large enough to handle the high currents and protect the system from IEC 61000-4-2 ESD event.

#### 4 Application Design

In order to design the TPD4S1394 into a system, it is important to understand the power source from the external source/power port. Shown in [Figure 5](#) is a simple example of how the TPD4S1394 can be used in an application to protect the IEEE1394 controller. If a DC/DC converter or a load switch is used, there must be an enable pin to that device. This pin can either be an active high or active low shutdown. The TPD4S1394 provides an active high shutdown signal (FWPWR\_EN) on the occurrence of a late-Vg event. The voltage level of this signal is equal to the controller supply or device supply of the TPD4S1394. The  $V_{CLMP}$  pin is a **No Connect** pin and is only useful for debug purposes to measure the internal reference voltage. This pin must be left open (not connected to any power supply or signal) under normal operating conditions. During the system design phase, this pin can be used for debugging by forcing an external voltage to it in order to trigger the comparator and get the FWPWR\_EN signal to go high.

In a normal mode of operation as shown in [Figure 3](#), an internal reference generator is connected to the  $V_{CLMP}$  pin and another reference voltage, both of these is fed to an internal comparator. By default, the output of the comparator to the FWPWR\_EN pin is high. When a late-Vg event occurs, the Tp lines start rising due to the power port supply being active. During the event, the data lines rise high enough that the **internal ESD clamp** is triggered, holding the lines at the breakdown voltage for the clamp.

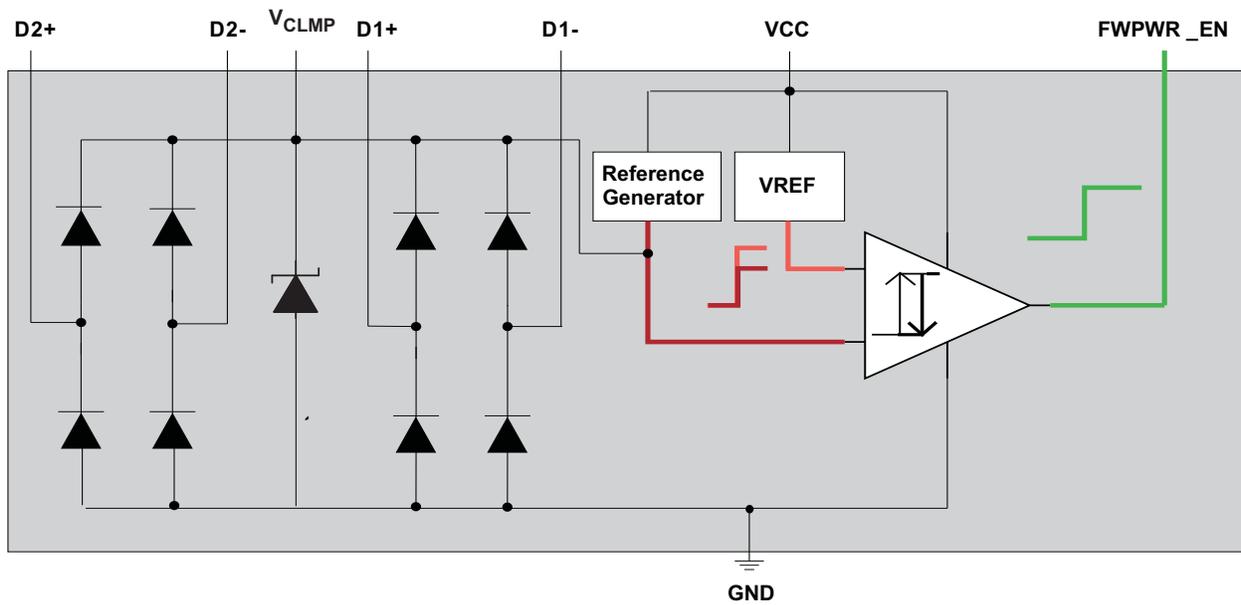


Figure 3. Output of FWPWR\_EN High Under Normal Operation

During this time, the internal comparator will trip as soon as the VCLAMP level crosses the comparator threshold. This will in turn cause FWPWR\_EN to immediately go low as shown in Figure 4. The comparator has an internal hysteresis to prevent noise from causing a false event. When proper connection has been established, the voltage on the Tp lines starts to return to their normal levels. When VCLAMP returns below the comparator threshold, there is an internal timer which prevents the FWPWR\_EN from going high immediately. The purpose of this timer is to ensure that the Tp voltage has gone down to sufficient levels for safe operation. Once the timer times out, then the FWPWR\_EN output goes to logic high.

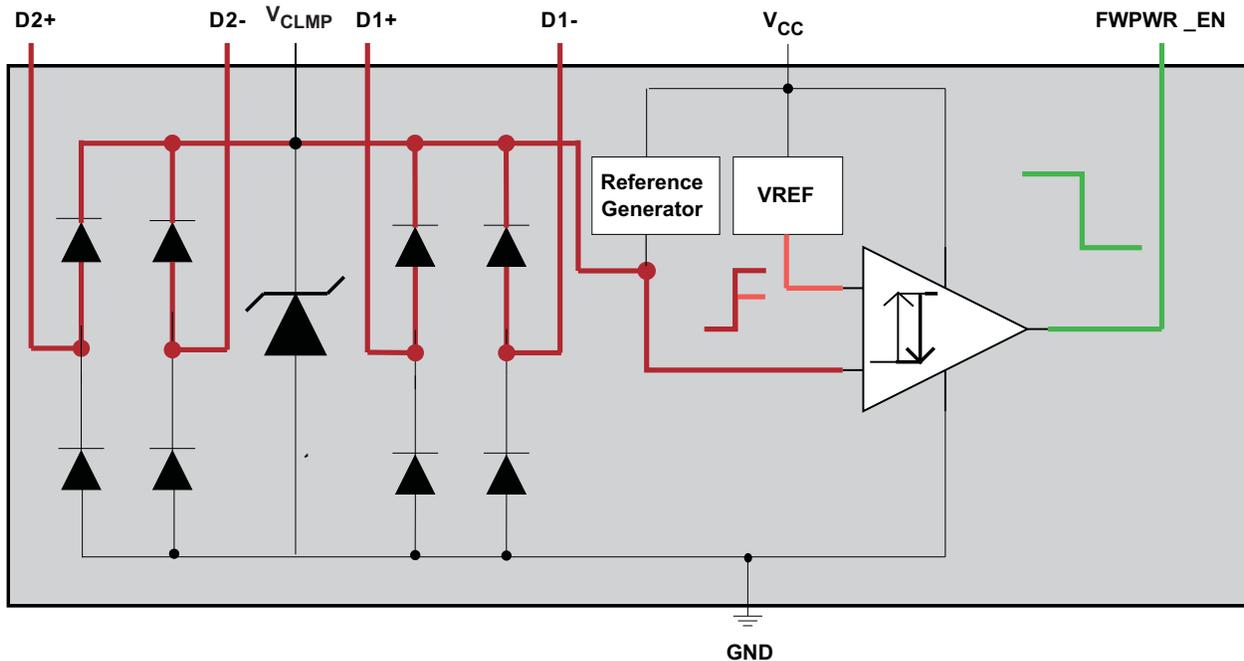


Figure 4. Output of FWPWR\_EN High Under Late-Vg Event

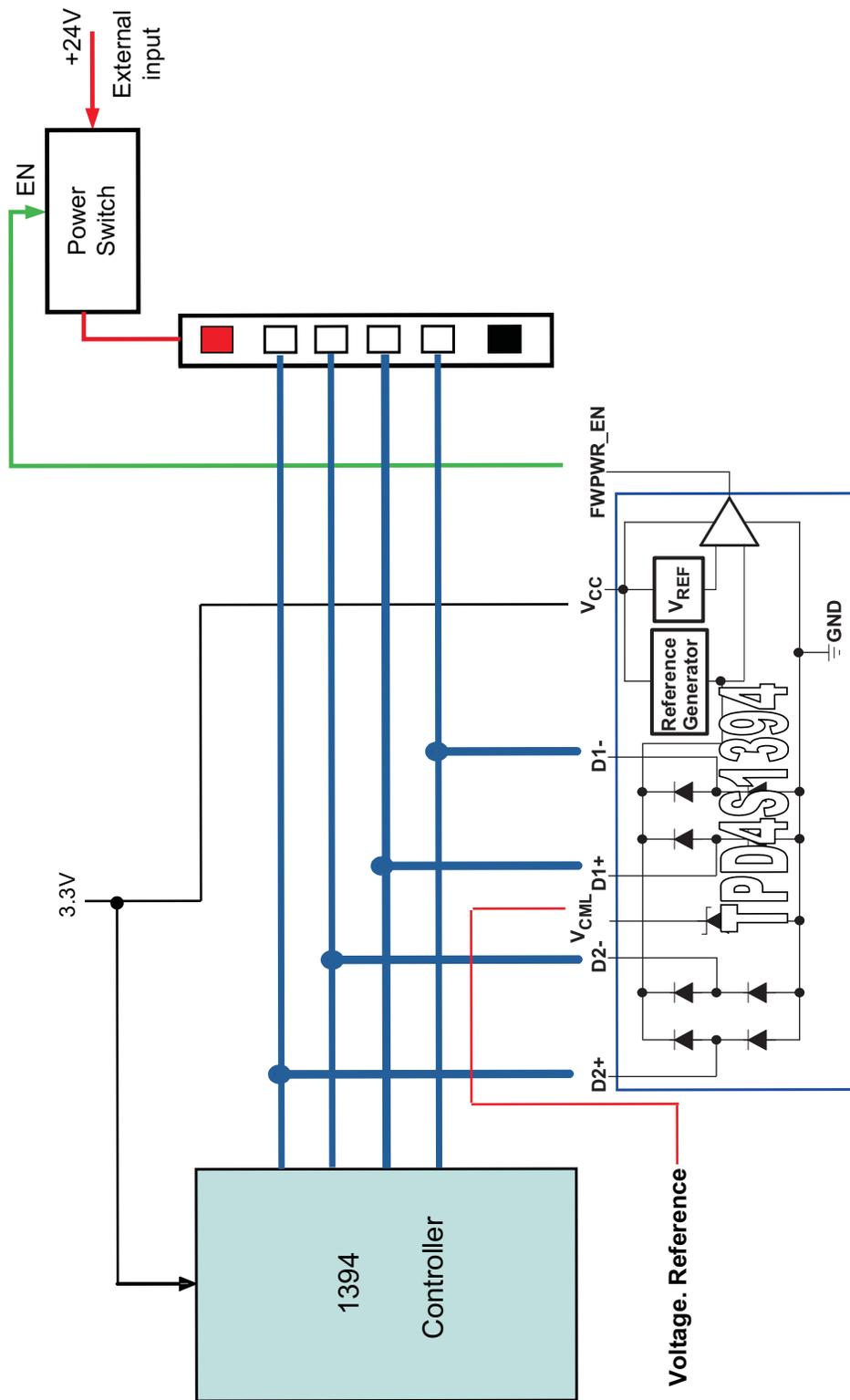


Figure 5. Application Diagram of TPD4S1394 with the 1394 Port Adapter

## 5 PCB Layout Consideration

It is important to have a good routing of the traces on the PCB to minimize capacitance for the Tp lines. The IEEE 1394 interface is not extremely high speed, but it is still beneficial to keep the above in consideration. Figure 6 shows the suggested PCB layout routing of the TPD4S1394 with respect to the connector and controller.

The data lines are connected in a way that there is no break of connectivity in the lines. The FWPWR\_EN signal is a digital output and therefore there should be no issue of routing it under the layer to the system power switch control. The Vclmp pin is a NO Connect (only used as a test point/input) and hence its position is not critical. A 0.1µF decoupling capacitor is required to be connected on Vcc.

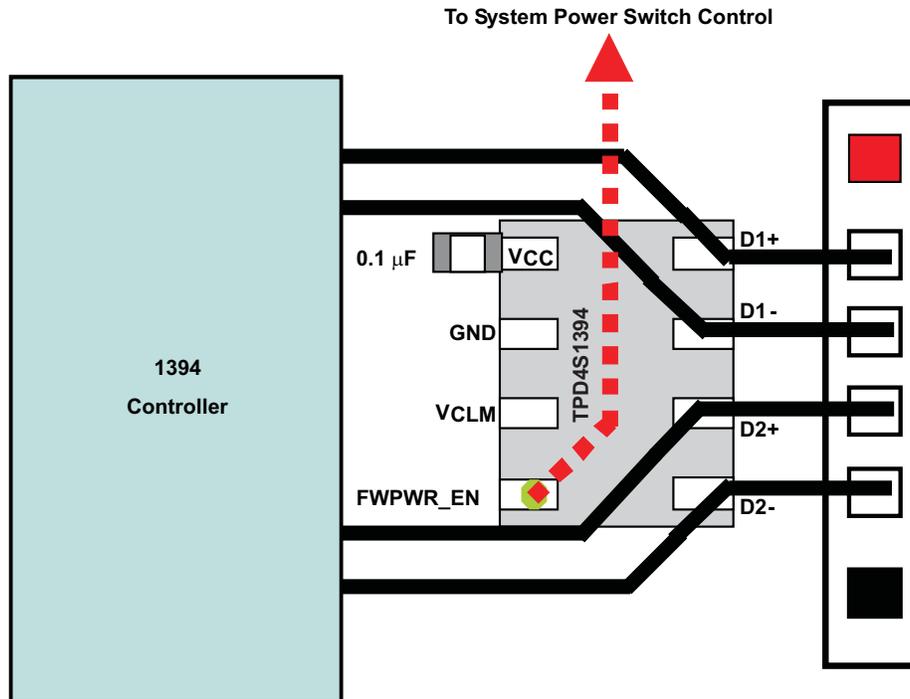


Figure 6. PCB Board Layout with TPD4S1394

## 6 Conclusion

The TPD4S1394 provides a robust solution to the EOS or late 'Vg' type event with the IEEE1394 lines. Though other means may be used to help guard against late-Vg (adding shielding, replacing older cables, or adding external components), the TPD4S1394 provides a simple and effective solution by turning off the switch which provides the path for the current to the Tp lines. With this solution, there is no chance of the Tp lines ever reaching such catastrophic voltage levels.

The TPD4S1394 also provides integrated ESD protection with a clamping voltage much lower than the absolute max for the protected device. This adds another level of protection if the response time of the switch is a little long. The above device can be used to protect IEEE1394 ports in laptops and desktops and other applications with IEEE1394 devices.

Visit [www.ti.com](http://www.ti.com) for data sheets for all TPD type protection devices of Texas Instruments. For more info about late-Vg event and causes, refer to Application Note ([SLEA072A](#)).

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